



HY30N10

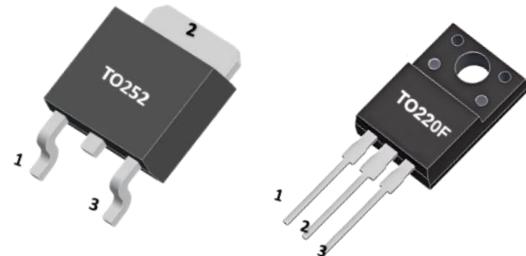
N-CHANNEL POWER MOSFET

30A, 100V N-CHANNEL ENHANCEMENT MODE POWER MOSFET

■ DESCRIPTION

The HY30N10A is a N-channel mode power MOSFET using our advanced technology to provide customers with a minimum on-state resistance, low gate charge and high switching speed. The HY30N10A is suitable for high voltage synchronous rectifier and DC/DC converters, etc.

The HY30N10A meet the ROHS and Green Product requirement with full function reliability approved.



■ FEATURE

- * High density cell design for ultra low RDS(on)
- * Fully characterized avalanche voltage and current
- * Good stability and uniformity with high EAS
- * Special process technology for high ESD capability
- * Excellent package for good heat dissipation

■ MARKING



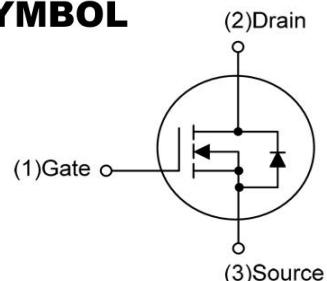
: HY LOGO

HY30N10A=Device Code

XXXX=Date Code

Solid Dot=Green molding compound

■ SYMBOL



■ ABSOLUTE MAXIMUM RATINGS(TA=25°C, unless otherwise specified.)

SYMBOL	PARAMETER		VALUE	UNIT
V _{DSS}	Drain-Source Voltage		100	V
V _{GSS}	Gate Source Voltage		±20	V
I _D	Continuous Drain Current (VGS=10V) TC=25°C		30	A
I _{DM}	Pulsed Drain Current		60	A
EAS	Single Pulsed Avalanche Energy (Note 2)		28	mJ
dV/dt	Peak Diode Recovery dV/dt (Note 4)		3.2	V/ns
P _D	Power Dissipation	TO-220F	28	W
		TO-252	44	
T _J	Storage Temperature		150	°C
T _{TSG}	Thermal Resistance Fr .00m Junction To Ambient		-55~150	°C
R _{θJA}	Thermal Resistance from Junction to Ambient	TO-220F	62.5	°C/W
		TO-252	110	
R _{θJC}	Thermal Resistance From Junction To Case (Note 5)	TO-220F	4.46	°C/W
		TO-252	2.85	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.



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Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=1mH, IAS=7.5A, VDD=50V, RG=25Ω, Starting TJ = 25°C

4. ISD ≤ 30A, di/dt ≤ 200A/μs, VDD ≤ BVDS, Starting TJ = 25°C

5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

ELECTRICAL CHARACTERISTICS (TA=25°C, unless otherwise specified)

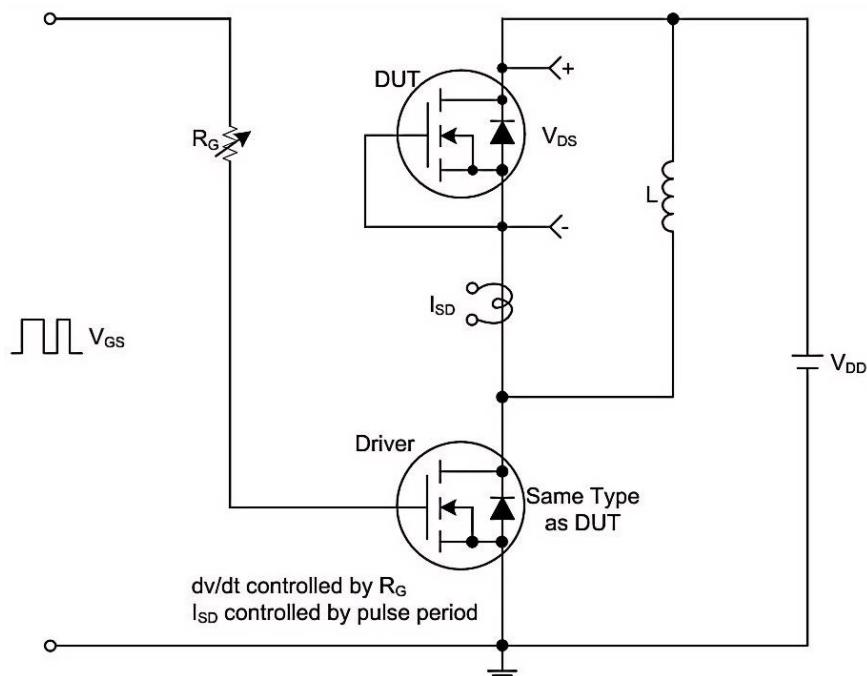
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	V _{(BR) DSS}	V _{GS} =0V, I _D =250μA	100			V
Zero gate voltage drain current	I _{DSS}	V _{Ds} =100V, V _{GS} =0V			1	μA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{Ds} =0V			±100	nA
ON CHARACTERISTICS						
Drain-source on-state resistance	R _{Ds(ON)}	V _{GS} =10V, I _D =30A			40	mΩ
		V _{GS} =4.5V, I _D =15A			52	mΩ
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{Ds} , I _D =250μA	1.0		3.0	V
DYNAMIC PARAMETERS						
Input Capacitance	C _{iss}	V _{GS} =0V, V _{Ds} =25V f=1.0MHz		1950		pF
Output Capacitance	C _{oss}			130		
Reverse Transfer Capacitance	C _{rss}			108		
SWITCHING PARAMETERS						
Total gate charge	Q _g	V _{Ds} =80V, V _{GS} =10V I _D =30A		75		nC
Gate-source charge	Q _{gs}			10.5		
Gate-drain charge	Q _{gd}			20		
Turn-On Delay Time	t _{d(on)}	V _{DD} =50V, I _D =30A V _{GS} =10V, R _G =3.3Ω		9		nS
Turn-On Rise time	t _r			18		
Turn-Off Delay Time	t _{d(off)}			40		
Turn-Off Fall time	t _f			20		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous drain-source diode forward current	I _s				30	A
Pulsed drain-source diode forward current	I _{SM}				60	A
Drain-Source Diode Forward Voltage	V _{SD}	I _s =30A, V _{GS} =0V			1.25	V
Body Diode Reverse Recovery Time	t _{rr}	I _S =30A, V _{GS} =0V dI _F /dt=100A/μs		45		ns
Body Diode Reverse Recovery Charge	Q _{rr}			44		



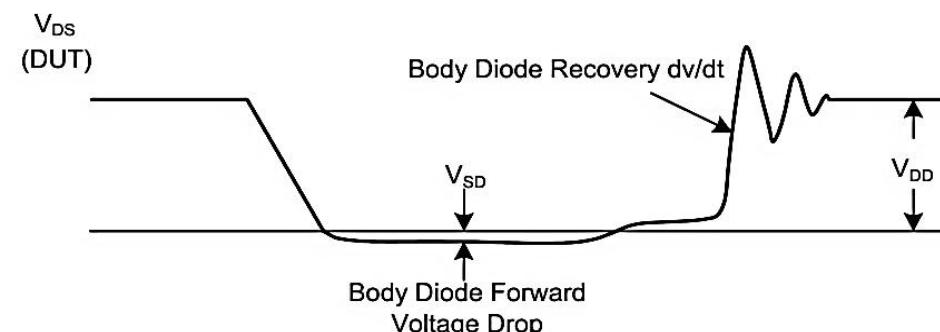
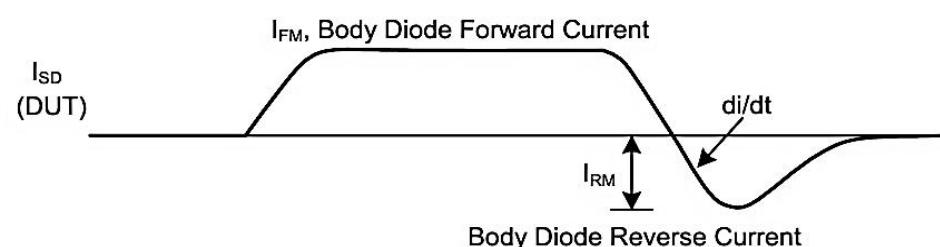
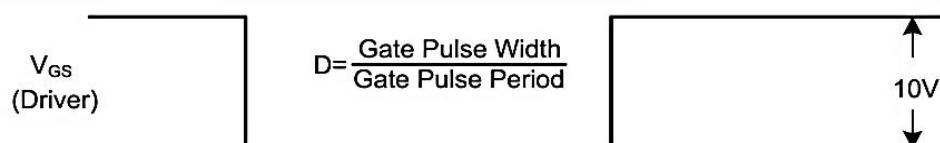
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■ TEST CIRCUITS AND WAVEFORMS(1)



Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Test Circuit and Waveforms

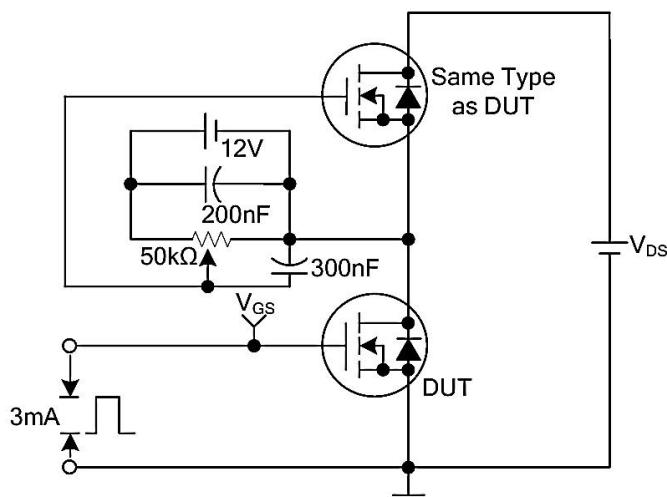
Peak Diode Recovery dv/dt Waveforms



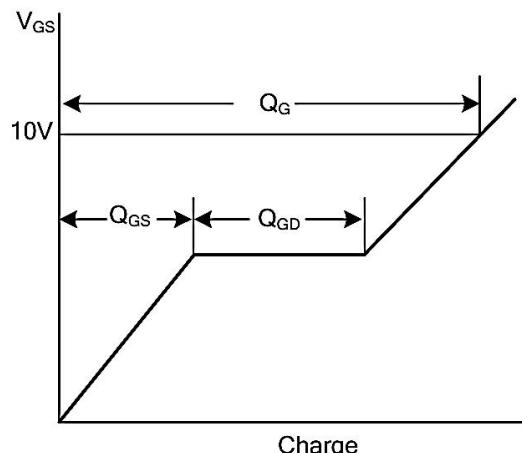
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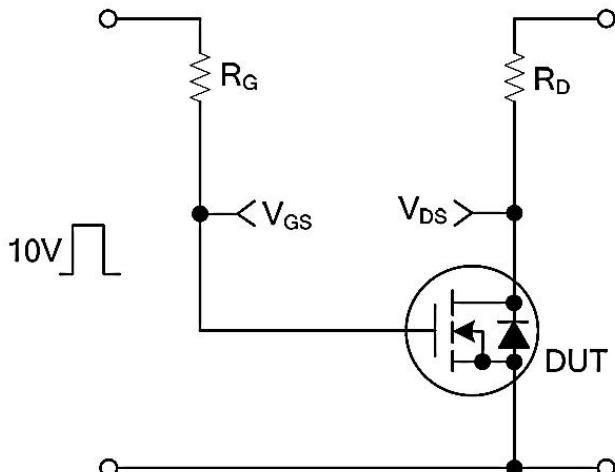
■ TEST CIRCUITS AND WAVEFORMS(2)



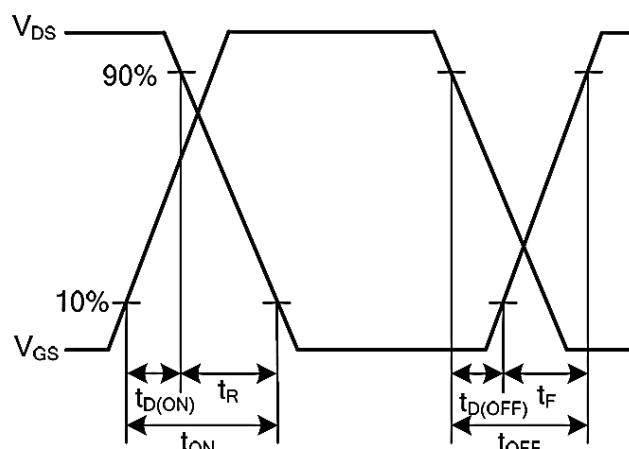
Gate Charge Test Circuit



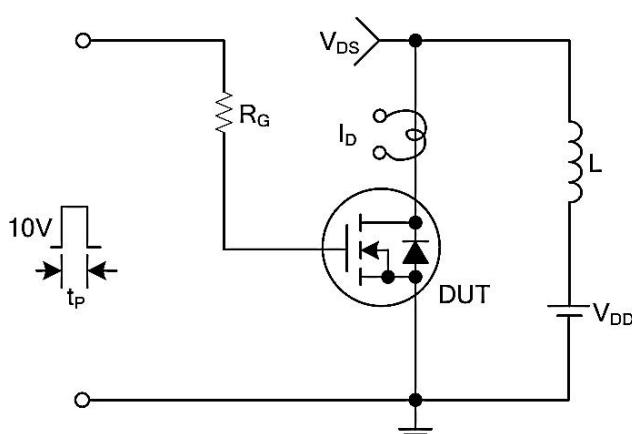
Gate Charge Waveforms



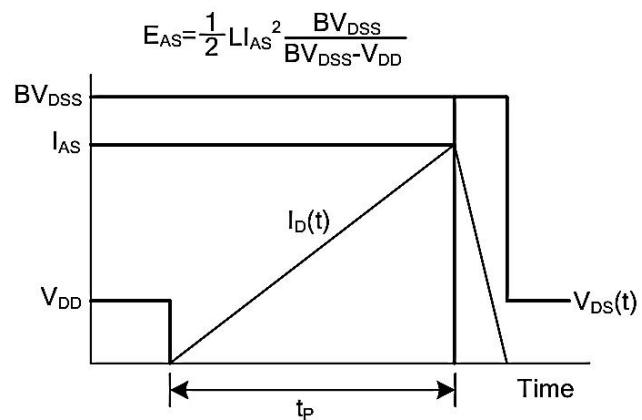
Resistive Switching Test Circuit



Resistive Switching Waveforms



Unclamped Inductive Switching Test Circuit



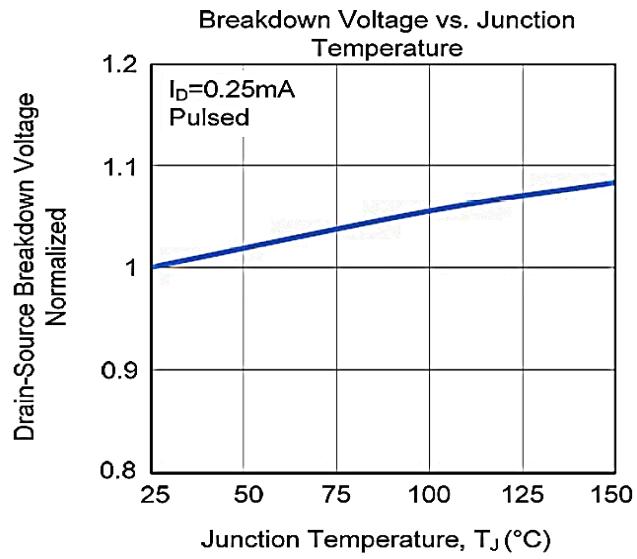
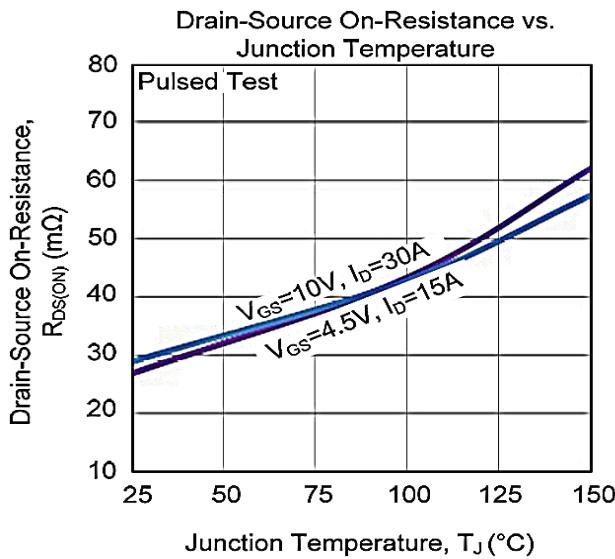
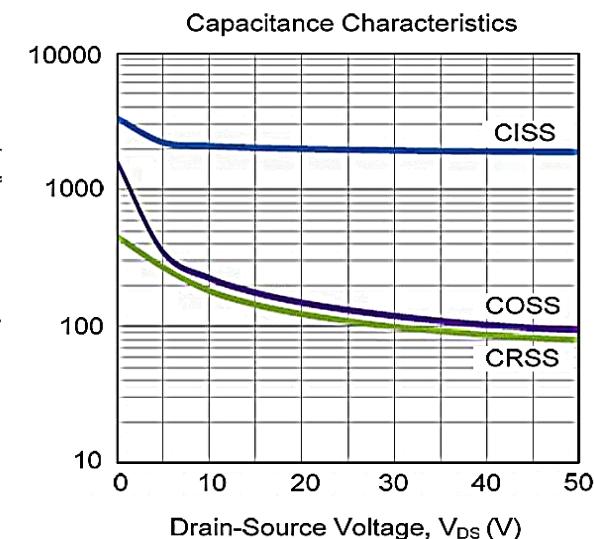
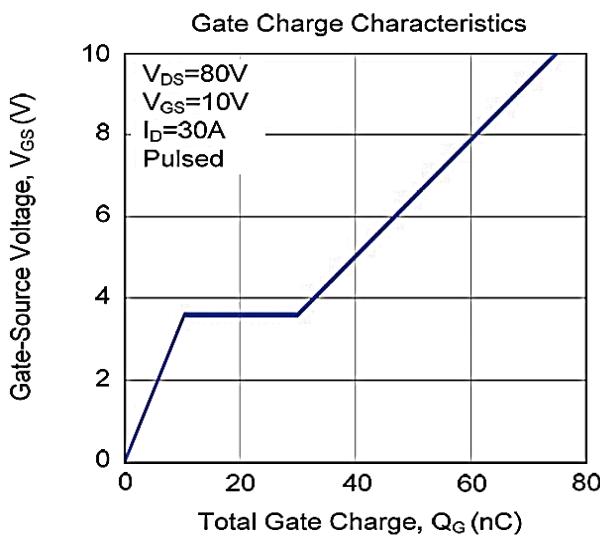
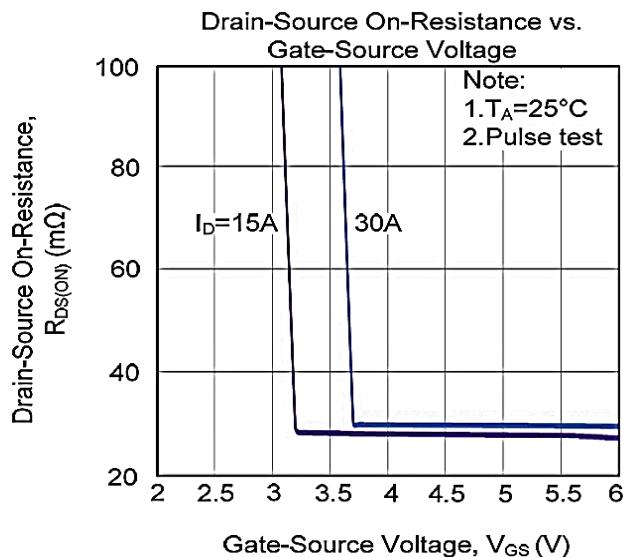
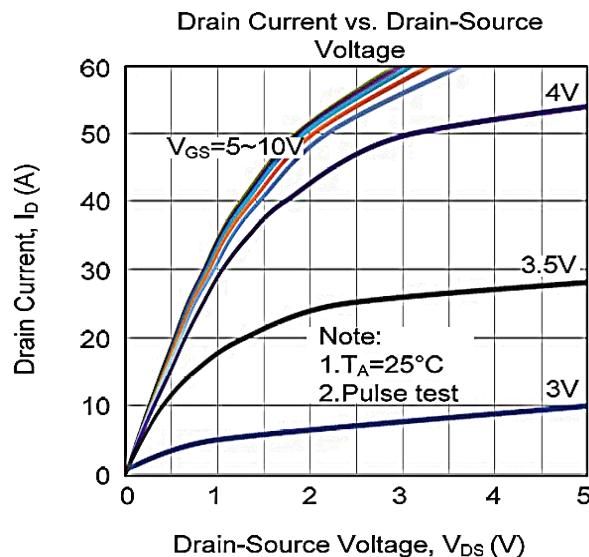
Unclamped Inductive Switching Waveforms



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■ TYPICAL CHARACTERISTICS

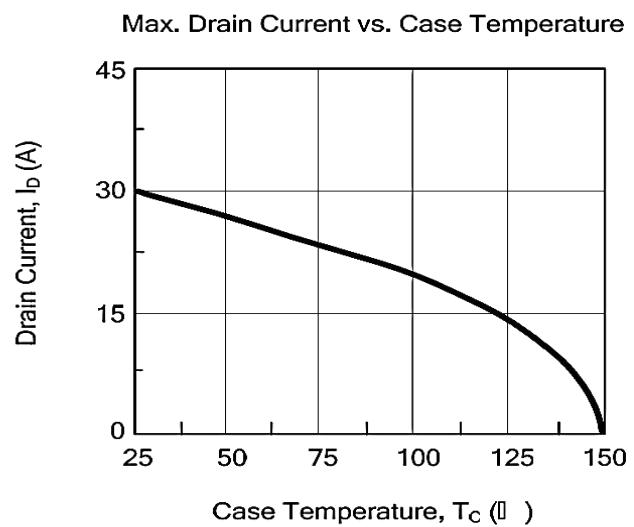
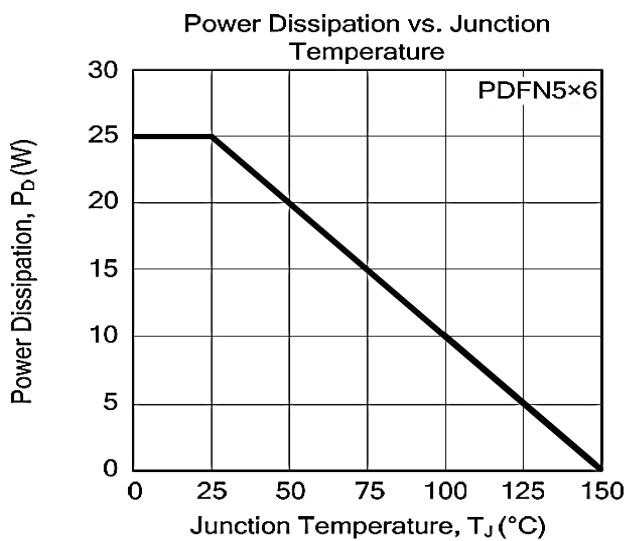
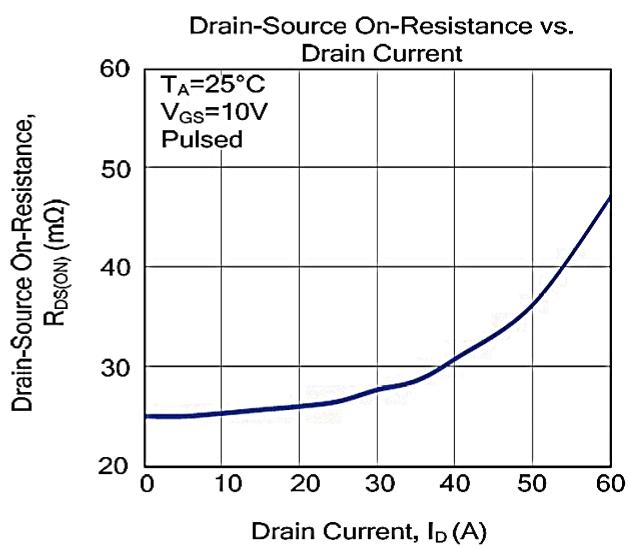
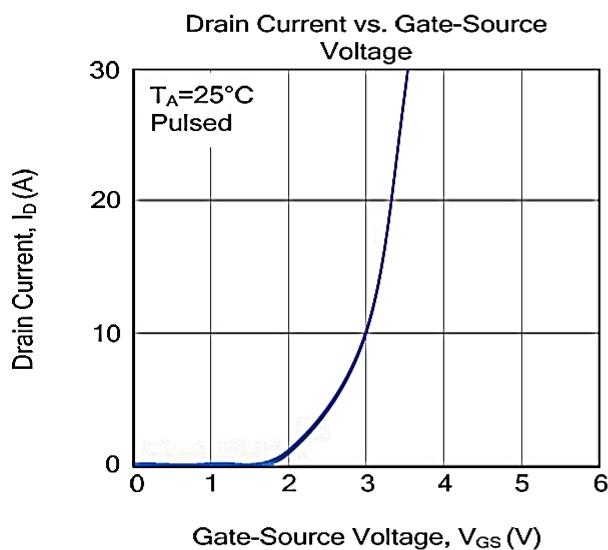
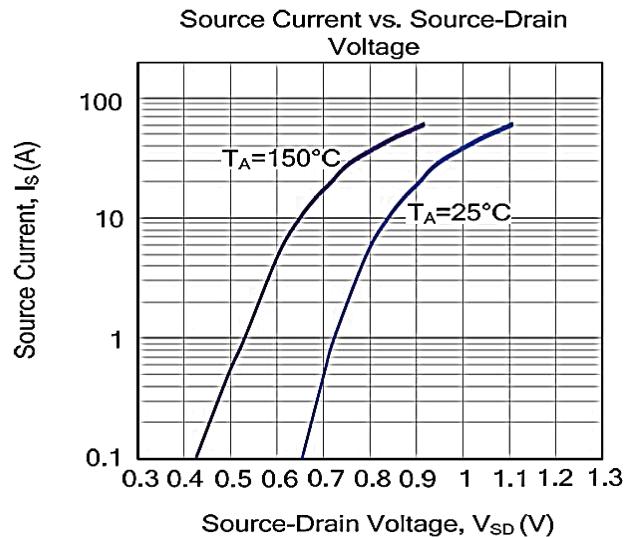
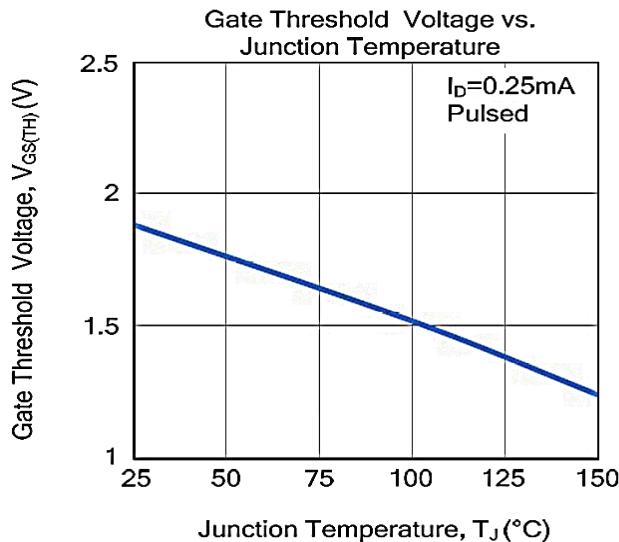




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■ TYPICAL CHARACTERISTICS(Con.t)

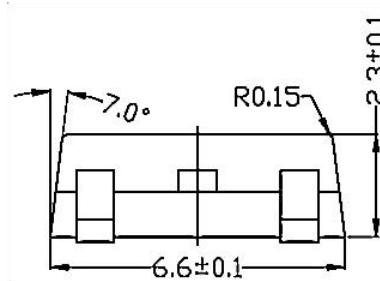
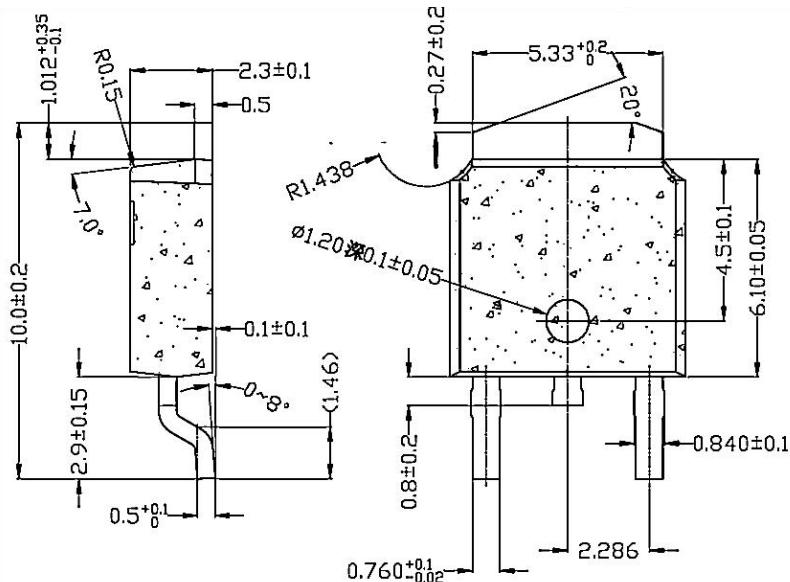




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■ TO - 252 PACKAGE OUTLINE DIMENSIONS



■ TO - 252 PACKING INFORMATION



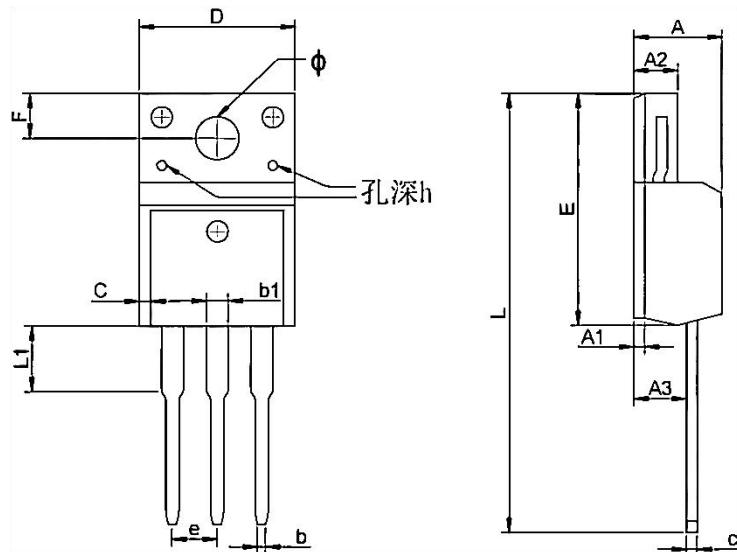
Package version	Reel dimensions $\Phi \times H$ (mm)	Per Reel (pcs)	Reels per box	Inner box dimensions L×W×H (mm)	Outer box (pcs)	Outer box dimensions L×W×H (mm)
T0-252	$\Phi 330 \times 20$	2500	2	360*340*50	25000	375*375*280



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■ TO- 220F PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max	Min	Max
A	4.300	4.750	0.169	0.185
A1	1.830 REF		0.072 REF	
A2	2.300	2.850	0.090	0.112
A3	2.500	2.900	0.098	0.114
b	0.400	0.420	0.016	0.016
b1	1.220	1.280	0.048	0.050
C	0.690	0.720	0.027	0.028
c	0.490	0.510	0.019	0.020
D	9.960	10.200	0.392	0.400
E	15.000	15.950	0.588	0.625
e	2.574 TYP		0.101TYP	
F	3.470 REF		0.136 REF	
y	3.200 REF		0.125 REF	
h	0.000	0.300	0.000	0.012
L	28.780	28.900	1.128	1.133
L1	2.990	3.100	0.117	0.122

■ TO - 220F PACKING INFORMATION



50PCS



5 Inner Box



20 Tube

Outer Box

Inner Box

Package version	Tube dimensions LxWxH (mm)	Per Tube (pcs)	Tube per box	Inner box dimensions LxWxH (mm)	PCS/Inner box	Outer box dimensions LxWxH(mm)	PCS/Outer box
TO-220F	530*32*7	50	20	580*155*50	1000	602*277*188	5000